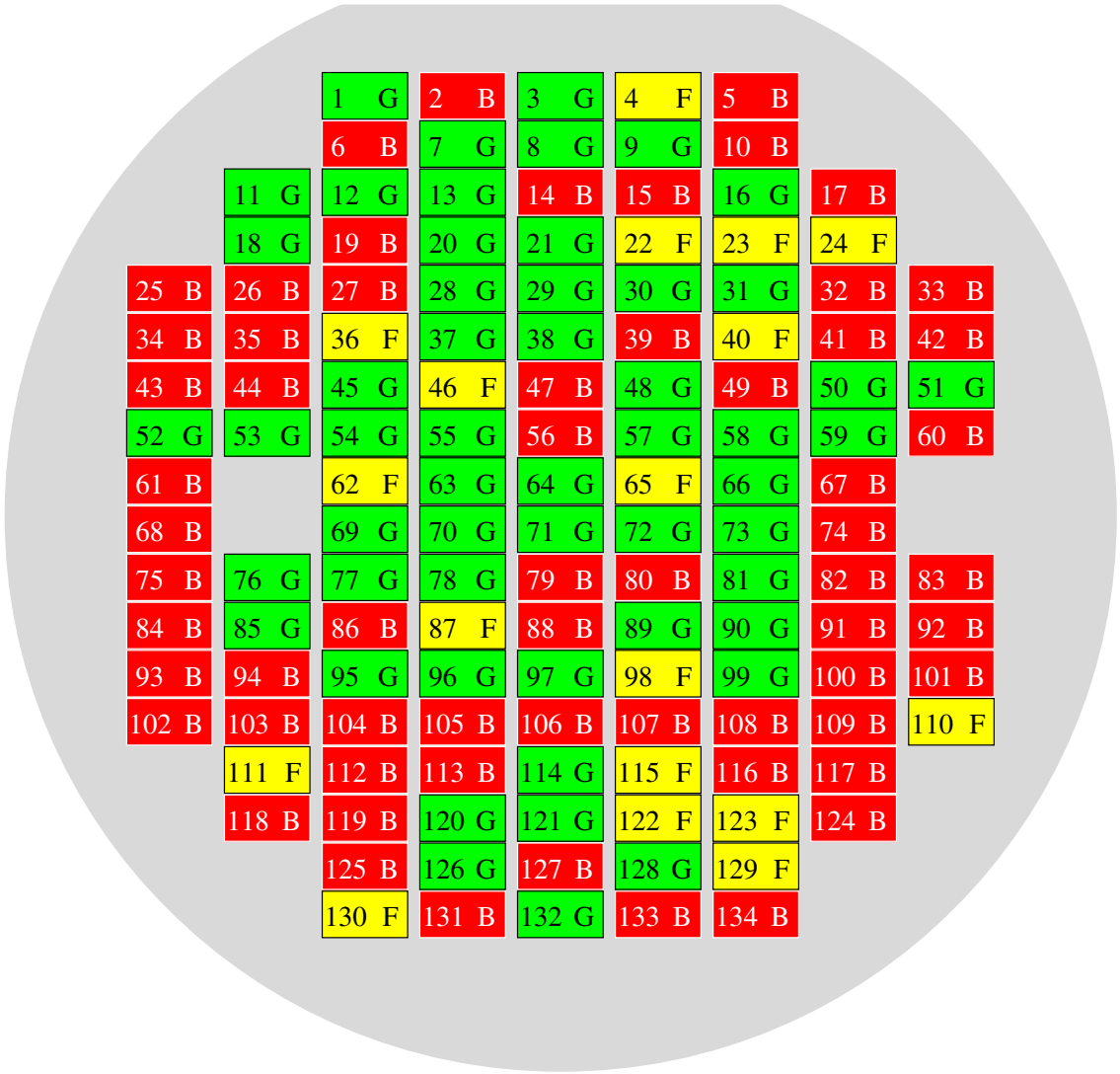
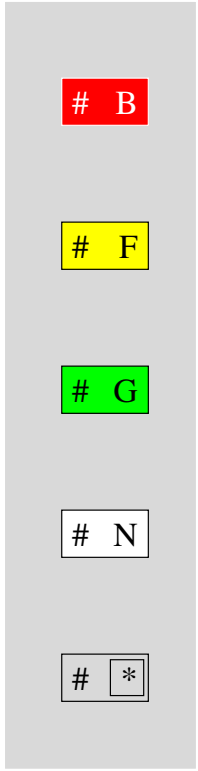
Die quality map for wafer 227 s/n: 21316-14-13

Date: 10/27/99





Bad die

Fair die

Good die

No info

Manually tagged